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14. ABSTRACT Nano/Micro-Mechanical characterization is one of the key elements for the development of material systems of many Department of Defense (DoD) applications. A group of researchers at University of Nevada, Las Vegas (UNLV), having diverse research interests, intended to establish our SEM imaging capabilities by adding an integrated nano-analysis capability as well as a mechanical testing system. The mechanical testing facility allows in-situ investigation of materials of interest by looking into stress/strain curves, shear, tensile, 3-point bend, Vickers Modulus, simultaneously allowing video, testing and generating other imaging reports. Furthermore, we					
15. SUBJECT TERMS Nano/Micro Characterization					
16. SECURITY CLASSIFICATION OF:			17. LIMITATION OF ABSTRACT UU	15. NUMBER OF PAGES	19a. NAME OF RESPONSIBLE PERSON Kwang Kim
a. REPORT UU	b. ABSTRACT UU	c. THIS PAGE UU			19b. TELEPHONE NUMBER 702-774-1419



## Report Title

Final Report: Establishment of a Versatile Nano\_Micro-Mechanical Characterization\_NMMC\_Facility

### ABSTRACT

Nano/Micro-Mechanical characterization is one of the key elements for the development of material systems of many Department of Defense (DoD) applications. A group of researchers at University of Nevada, Las Vegas (UNLV), having diverse research interests, intended to establish our SEM imaging capabilities by adding an integrated nano-analysis capability as well as a mechanical testing system. The mechanical testing facility allows in-situ investigation of materials of interest by looking into stress/strain curves, shear, tensile, 3-point bend, Young's Modulus; simultaneously, allowing video-taping and generating other imaging reports. Furthermore, we added the capability of testing biological samples to make this SEM readily available for researchers who are in the field of biological sciences and engineering. In addition to the tabletop SEM, we also installed a Scanning ElectroChemical Workstation (SECW) that is advanced equipment for scanning probe electrochemistry designed for ultra-high resolution, non-contact, spatially resolved electrochemical measurements. This SECW helps UNLV students and researches to study through membranes, monitor biological activity, image chemical biosystems, and perform fuel cell materials, surface science, and corrosion science research.

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**Enter List of papers submitted or published that acknowledge ARO support from the start of the project to the date of this printing. List the papers, including journal references, in the following categories:**

**(a) Papers published in peer-reviewed journals (N/A for none)**

Received

Paper

**TOTAL:**

**Number of Papers published in peer-reviewed journals:**

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**(b) Papers published in non-peer-reviewed journals (N/A for none)**

Received

Paper

**TOTAL:**

**Number of Papers published in non peer-reviewed journals:**

---

**(c) Presentations**

Number of Presentations: 0.00

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**Non Peer-Reviewed Conference Proceeding publications (other than abstracts):**

Received      Paper

**TOTAL:**

Number of Non Peer-Reviewed Conference Proceeding publications (other than abstracts):

---

**Peer-Reviewed Conference Proceeding publications (other than abstracts):**

Received      Paper

**TOTAL:**

Number of Peer-Reviewed Conference Proceeding publications (other than abstracts):

---

**(d) Manuscripts**

Received      Paper

**TOTAL:**

Number of Manuscripts:

Books

Received      Book

TOTAL:

Received      Book Chapter

TOTAL:

Patents Submitted

Patents Awarded

Awards

The PI, Kwang Kim was awarded the 2015 Nevada Board of Regents' Researcher Award in March 2015.

Graduate Students

NAME	PERCENT_SUPPORTED	Discipline
Shelby Nelson	0.00	
Blake Naccarato	0.00	
Sarah Trabia	0.00	
Qi Shen	0.00	
Tyler Stalbaum	0.00	
FTE Equivalent:	0.00	
Total Number:	5	

### Names of Post Doctorates

<u>NAME</u>	<u>PERCENT SUPPORTED</u>
Viljar Palmre	0.00
Taeseon Hwang	0.00
Aupam Kumar	0.00
<b>FTE Equivalent:</b>	<b>0.00</b>
<b>Total Number:</b>	<b>3</b>

### Names of Faculty Supported

<u>NAME</u>	<u>PERCENT SUPPORTED</u>	National Academy Member
Kwang Kim	0.00	
<b>FTE Equivalent:</b>	<b>0.00</b>	
<b>Total Number:</b>	<b>1</b>	

### Names of Under Graduate students supported

<u>NAME</u>	<u>PERCENT SUPPORTED</u>	Discipline
Blake Naccarato	0.00	Mechanical Engineering
Zakai Olsen	0.00	Mechanical Engineering
<b>FTE Equivalent:</b>	<b>0.00</b>	
<b>Total Number:</b>	<b>2</b>	

### Student Metrics

This section only applies to graduating undergraduates supported by this agreement in this reporting period

The number of undergraduates funded by this agreement who graduated during this period: ..... 1.00

The number of undergraduates funded by this agreement who graduated during this period with a degree in science, mathematics, engineering, or technology fields:..... 1.00

The number of undergraduates funded by your agreement who graduated during this period and will continue to pursue a graduate or Ph.D. degree in science, mathematics, engineering, or technology fields:..... 1.00

Number of graduating undergraduates who achieved a 3.5 GPA to 4.0 (4.0 max scale):..... 1.00

Number of graduating undergraduates funded by a DoD funded Center of Excellence grant for Education, Research and Engineering:..... 0.00

The number of undergraduates funded by your agreement who graduated during this period and intend to work for the Department of Defense ..... 0.00

The number of undergraduates funded by your agreement who graduated during this period and will receive scholarships or fellowships for further studies in science, mathematics, engineering or technology fields:..... 1.00

### Names of Personnel receiving masters degrees

<u>NAME</u>
Shelby Nelson
<b>Total Number:</b>

### Names of personnel receiving PHDs

<u>NAME</u>
<b>Total Number:</b>

---

**Names of other research staff**

NAME

PERCENT SUPPORTED

**FTE Equivalent:**

**Total Number:**

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**Sub Contractors (DD882)**

**Inventions (DD882)**

## Scientific Progress



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- E. Example Images Taken at NMMC
- F. Work Plan
- G. Major Problem/Issues
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### A. Establishment of a Versatile Nano/Micro-Mechanical Characterization Facility

Nano/Micro-Mechanical characterization is one of the key elements for the development of material systems of many Department of Defense (DoD) applications. A group of researchers at University of Nevada, Las Vegas (UNLV), having diverse research interests, intended to establish our SEM imaging capabilities by adding an integrated nano-analysis capability as well as a mechanical testing system. The mechanical testing facility allows in-situ investigation of materials of interest by looking into stress/strain curves, shear, tensile, 3-point bend, Young's Modulus; simultaneously, allowing video-taping and generating other imaging reports. Furthermore, we added the capability of testing biological samples to make this SEM readily available for researchers who are in the field of biological sciences and engineering. In addition to the tabletop SEM, we also installed a Scanning ElectroChemical Workstation (SECW) that is advanced equipment for scanning probe electrochemistry designed for ultra-high resolution, non-contact, spatially resolved electrochemical measurements. This SECW helps UNLV students and researches to study through membranes, monitor biological activity, image chemical biosystems, and perform fuel cell materials, surface science, and corrosion science research.

Establishment of such a versatile Nano/Micro-Mechanical Characterization (NMMC) facility greatly helped advance state-of-the-art materials research at UNLV. The established NMMC facility is now being used in all the DoD-related research projects as well as other scientific research at the UNLV campus.

### B. Table-Top SEM

A new tabletop SEM was purchased from Hitachi High Technologies America, Inc. (Model # TM3030, see Fig. 1). It is capable of generating high contrast and sharp images even at a high magnification. It is equipped with a low-vacuum mode owing to which no special sample preparation is necessary. Our SEM is integrated with an EDX unit to analyze the chemical components of materials under SEM in addition to a nano-/micro-scale mechanical testing system. The SEM can be used accelerating voltages of 5 kV, 10 kV, and 15 kV. Samples with diameters up to 70 mm and thicknesses up to 50 mm can be tested with the facility producing a magnification of about 15x–30,000x.

Additionally, the samples can be moved up to 35 mm in both X and Y directions. This table-top SEM is also capable of special stages like motorized stage, tilt rotate stage, and cooling stage (which is useful when imaging biological systems). All these features enable the SEM for advanced topographic imaging with a large depth of focus. One of the advantages arising out of the incorporation of mechanical testing feature in the SEM is that one can see the electron micrograph of the samples while tensile or compression testing is being performed. The SEM is appropriate for a wide range of research which includes materials, entomology, medicine, food, botany, cosmetics, semiconductor, textiles, and environment.

### C. Scanning ElectroChemical Workstation (SECW)

In addition to the tabletop SEM, the UNLV's NMMC facility also installed a Scanning ElectroChemical Workstation (SECW) bought from Uniscan Instruments, Inc. (Model # M370, see Fig. 2). It is an advanced equipment for scanning probe electrochemistry designed for ultra-high resolution, non-contact, spatially resolved electrochemical measurements. It possesses a fast and precise positioning system with micro/nanometer resolution, along with a flexible data acquisition to select the configuration most suited for a particular experiment. The system is capable of being used in applications ranging from flow through membranes, monitoring biological activity, imaging of chemical biosystems (including immobilized enzymes), fuel cell materials research, and surface and corrosion science.

### D. Other Equipment

Other miscellaneous equipment including a critical point dryer and a sputter coater were purchased and installed in room SEB 1119 (Electron Microanalysis and Imaging Laboratory. See Fig. 3).

Sputtering System: We acquired a sputtering system from Denton Vacuum, Inc. (Model # DSK00V-0018) which is capable of depositing a large variety of coating materials (including iridium). The adjustable rotating and tilting stage ensures a highly uniform coating even on samples with highly irregular surfaces. It is capable of converting easily from metal sputter to carbon evaporation and is equipped with a turbo pump. The high resolution magnetron sputtering system is capable of depositing a conductive coating not only for scanning electron microscopy (SEM), but also for transmission electron microscopy (TEM) sample preparation.

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#### E. Example Images Taken at NMMC

Below shows a variety of images taken by the table top SEM.

#### F. Work Plan

All the equipment was purchased and installed properly. They are operational.

#### G. Major Problem/Issues

None.

#### H. Project-related Publications

J.2 A New Ionic Polymer-Metal Composite Based on Nafion / poly(vinyl alcohol-co-ethylene) Blends  
T. Hwang, V. Palmre, J. Nam, D.-C. Lee, and K. J. Kim  
(submitted for review)

J.1 A Comprehensive Physics-Based Model Encompassing Variable Surface Resistance and Underlying Physics of Ionic Polymer-Metal Composite Actuators  
Q. Shen, V. Palmre, T. Stalbaum, and K. J. Kim  
(submitted for review)

### **Technology Transfer**

# Final Report

**Project Title:** Establishment of a Versatile Nano/Micro-Mechanical Characterization Facility

Award Number: W911NF-14-1-0090

PIs Name: Kwang J. Kim<sup>1</sup> (PI) and 9 Co PIs<sup>2</sup>

Organization: University of Nevada, Las Vegas

Period: 12 February 2014 – 11 February 2015

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<sup>1</sup> South West Gas Professor of Energy and Matter, Mechanical Engineering Department, University of Nevada, Las Vegas, 4505 Maryland Parkway, Las Vegas, NV 89154-4027, Office: 702-774-1419 ([kwang.kim@unlv.edu](mailto:kwang.kim@unlv.edu))

<sup>2</sup> Jaci Batista, Dept. of Civil and Environmental Eng., UNLV; Thomas Hartmann, Dept. of Mechanical Eng., UNLV; David W. Hatchett, Department of Chemistry, UNLV; Brendan O'Toole, Dept. of Mechanical Eng., UNLV; Laurel A. Raftery, School of Life Sciences, UNLV; Mohamed Trabia, Dept. of Mechanical Eng., UNLV; Woosoon Yim, Dept. of Mechanical Eng., UNLV; and Hui Zhao, Dept. of Mechanical Eng., UNLV

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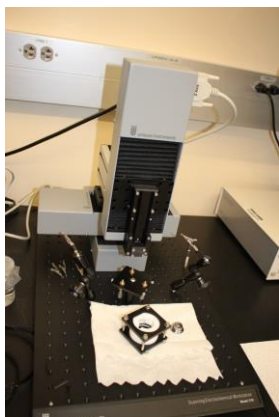


**Figure 1. Tabletop SEM**  
(installed in room SEB 2112A)

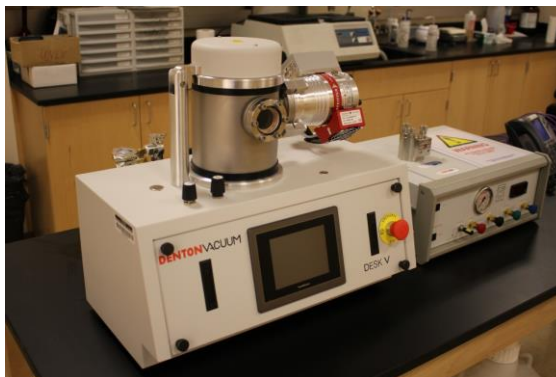
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**Figure 2. Scanning ElectroChemical Workstation (SECW)**  
(installed in room SEB 2112A)



**Figure 3. Sputtering System and Critical Point Dryer**  
(installed in room SEB 1119)

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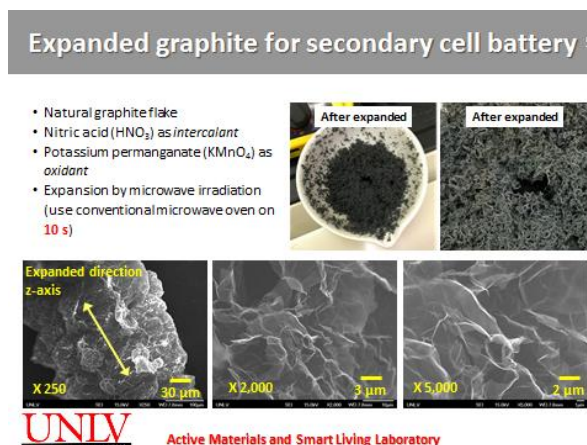
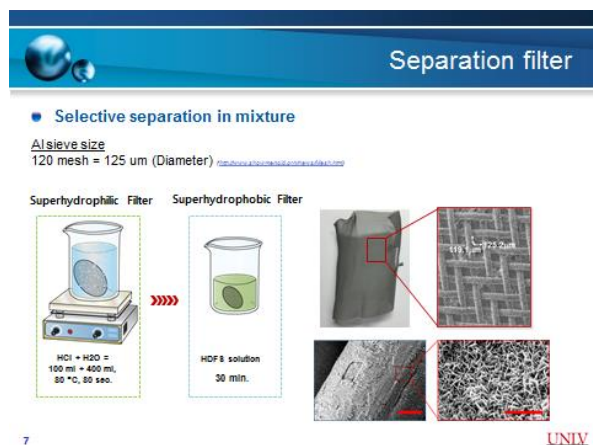
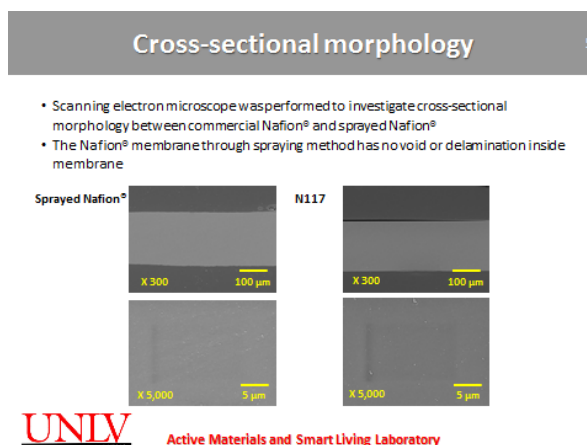
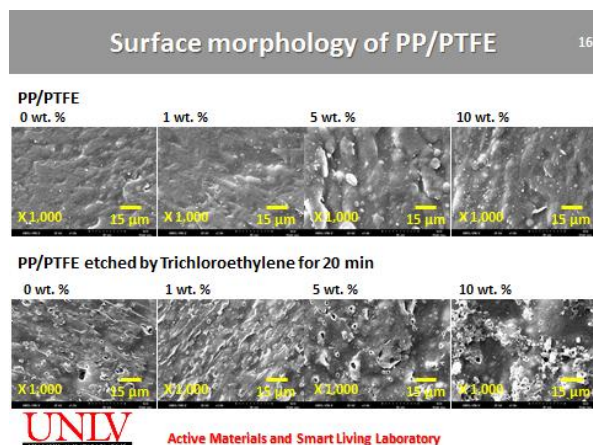


Figure 4. Various Images

## F. Work Plan

All the equipment was purchased and installed properly. They are operational.

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None.

## **H. Project-related Publications**

### **J.2 A New Ionic Polymer-Metal Composite Based on Nafion / poly(vinyl alcohol-co-ethylene) Blends**

T. Hwang, V. Palmre, J. Nam, D.-C. Lee, and K. J. Kim  
(submitted for review)

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(submitted for review)



## Appendix – I



**Figure Appendix-1. Exterior of Science and Engineering Building at UNLV**



**Figure Appendix-2. Science and Engineering Building Floor Plan for 2212**  
(The SEM and SECW are located in 2112A)